Automated identification of application-dependent safe faults in automotive systems-on-a-chips
Bagbaba, Ahmet Cagri; Augusto da Silva, Felipe; Sonza Reorda, Matteo; Hamdioui, Said; **Jenihhin, Maksim**; Sauer, Christian
Electronics 2022 / art. 319 https://doi.org/10.3390/electronics11030319 Journal metrics at Scopus Article at Scopus Journal metrics at WOS Article at WOS

Determined-safe faults identification : a step towards ISO26262 hardware compliant designs
Augusto da Silva, Felipe; **Bagbaba, Ahmet Cagri**; Sartoni, Sandro; Cantoro, Riccardo; Sonza Reorda, Matteo; Hamdioui, Said; Sauer, Christian 2020 25th IEEE European Test Symposium (ETS) 2020 / 6 p. : ill https://doi.org/10.1109/ETS48528.2020.9131568